GaNPOWER
GaNPower International Inc.

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230 -3410 LOUGHEED HWY
VANCOUVER, BC, V5M 2A4 CANADA

GPI65060DFN

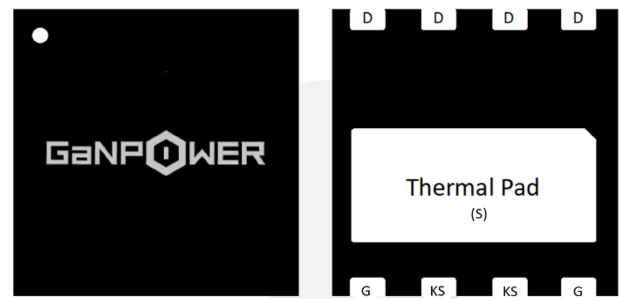
N-channel 650 V 60 A GaN Power HEMT in DFN8x8 package

Datasheet version: 1.0

Features

BV_{dss}	R_{dson}	I_{ds}	Q_g
650 V	25 mΩ	60 A	16 nC

- Ultra-low R_{DS}(on)
- High dv/dt capability
- Extremely low input capacitance
- Zero Qrr
- Outstanding switching performance
- Low Profile



Applications

- Switching Power Applications
- Server and Telecom Power Applications
- EV OBC and DC-DC Converters

Description

These devices are N-channel 650 V Power GaN HEMTs based on proprietary E-mode GaN on silicon technology. The resulting product has extremely low on state resistance, very low input capacitance and zero reverse recovery charge making it especially suitable for applications which require superior power density, ultra-high switching frequency and outstanding efficiency.

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Device Characteristics

Static Parameters				Test data			
	Parameters		**Conditions**	**Min**	**Typical**	**Max**	**Unit**
1	$V_{gs(TH)}$	Gate threshold voltage	$V_{ds}=V_{gs}$ Id=3.5mA	1.0	1.2	1.4	V
2	BV_{dss}	Drain-Source breakdown voltage	V_{gs}=0V I_d=25uA		650		V
3	I_{dss}	Zero gate voltage drain current, T_C = 25℃	V_{gs}=0V V_{ds}=650V		1.5	50	uA
4	I_{gss}	Gate-Source Leakage	V_{gs} = 6V V_{ds} =0V		347		uA
5	R_{dson}	Static drain-source on resistance, T_C = 25℃	V_{gs}=6V I_d=2.5A		25	35	mΩ
6	V_{sd}	Reverse conduction voltage	I_{sd}=1A V_{gs}=0V	1.55	1.75	2.0	V
7	R_g	Gate resistance	F=25MHz Open drain		2.18		Ω

Dynamic Parameters				Test data			
	Parameters		**Conditions**	**Min**	**Typical**	**Max**	**Unit**
1	C_{iss}	Input capacitance	V_{gs}=0V V_{ds}=400V f=1MHz		420		pf
	C_{oss}	Output capacitance			143		pf
	C_{rss}	Reverse transfer capacitance			6		pf
3	Q_g	Gate charge	V_{ds}=400V I_d=7.5A V_{gs}=6V		16.1		nC
	Q_{gs}	Gate to source charge			1.1		nC
	Q_{gd}	Gate to drain charge			1.8		nC
2	Q_{rr}	Reverse recovery charge			0		nC

Switching Performance				Test data			
	Parameters		**Conditions**	**Min**	**Typical**	**Max**	**Unit**
1	$t_{d(on)}$	Turn-on delay time	V_{ds}=400V I_d=2.5A R_g=10Ω V_{gs}=6V		9		ns
2	t_r	Rise time			17		ns
3	$t_{d(off)}$	Turn-off delay time			26		ns
4	t_f	Fall time			17		ns

Absolute Max. Ratings

	Symbols	Parameters	Value	Unit
1	$V_{DS\text{-}max}$	Breakdown voltage transient @ T_{case}=25ºC	800	V
2	$V_{GS\text{-}max}$	Gate to source max. transient voltage @ T_{case}=25ºC	-12 to +7.5	V
3	$I_{ds\text{-}max}$	Drain to source DC current @ T_{case}=25ºC	60	A
4	$I_{ds\text{-}max}$	Drain to source DC current @ T_{case}=100ºC	50	A
5	$dv/dt_{\text{-}max}$	Drain to source voltage slew rate	200	V/ns
6	$T_{J\text{-}max}$	Max junction temperature	150	ºC
7	$T_{S\text{-}storage}$	Storage temperature	-55 to 150	ºC

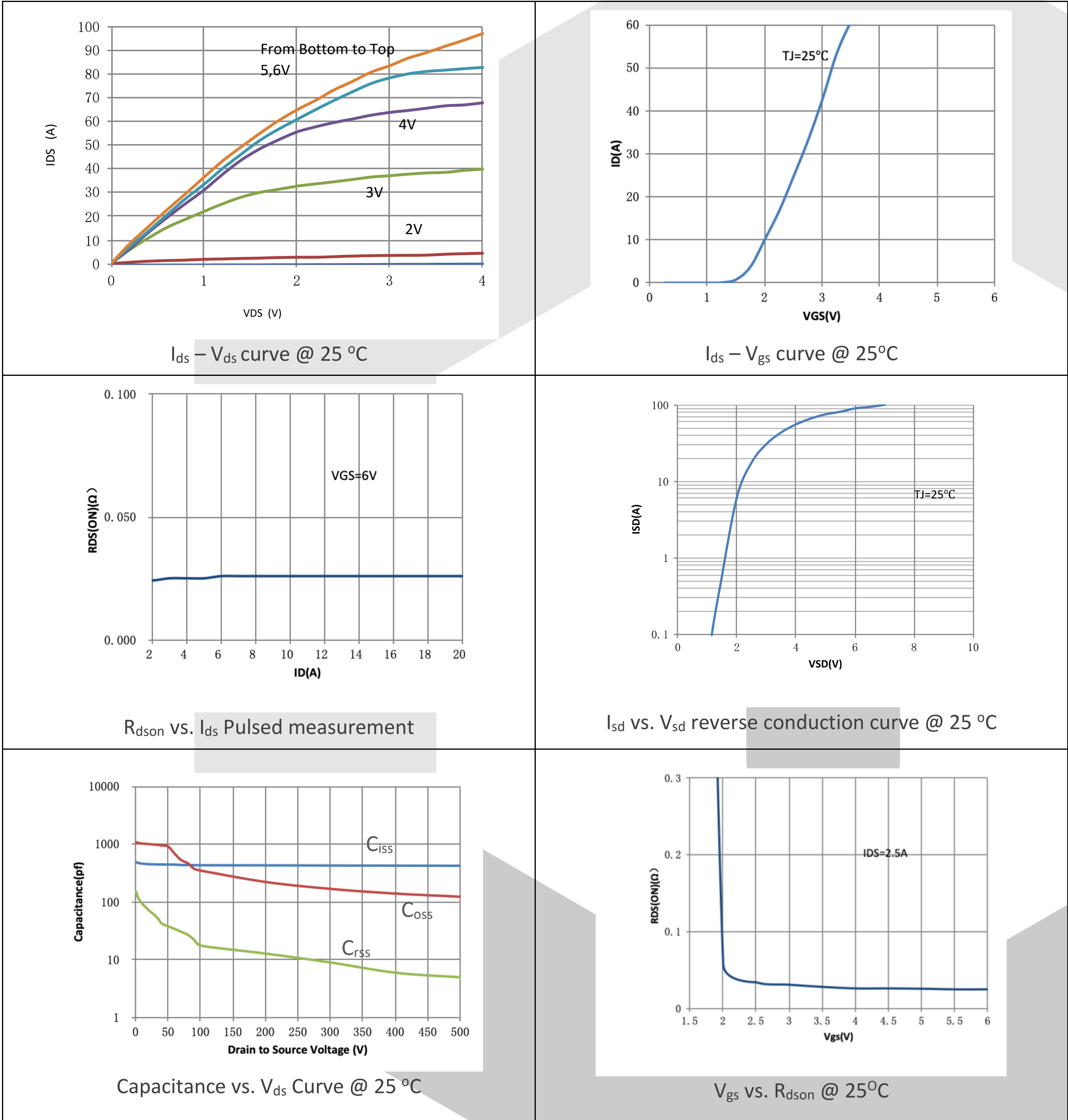
Thermal and Soldering Characteristics (Typical)

	Symbols	Parameters	Value	Unit
1	R_{thJC}	Thermal resistance (junction to case)	0.6	ºC /W
2	R_{thJA}	Thermal resistance (junction to ambient)	62	ºC /W
2	T_{solder}	Reflow soldering temperature	260	ºC

Ordering

Order Code	Package Type	Packaging Method	Qty
GPI65060DFN	DFN 8x8	QFN/DFN-Tray	100

Electrical Performance



$I_{ds} – V_{ds}$ curve @ 25 °C

$I_{ds} – V_{gs}$ curve @ 25°C

R_{dson} vs. I_{ds} Pulsed measurement

I_{sd} vs. V_{sd} reverse conduction curve @ 25 °C

Capacitance vs. V_{ds} Curve @ 25 °C

V_{gs} vs. R_{dson} @ 25°C

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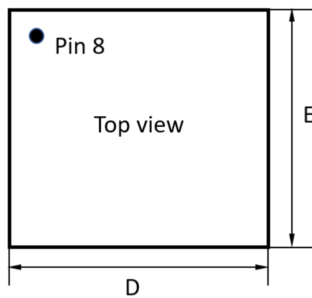
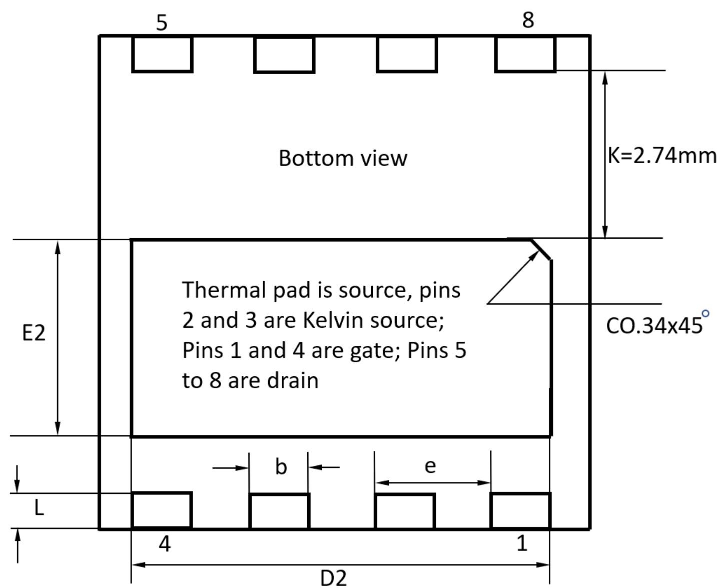
Package Information





D=8; E=8; e=1.95; b=0.97; L=0.57; D2=6.82; E2=3.19

8LEAD DFN (8x8x0.75mm, Pitch 1.95mm)
IMPORTANT: Please connect the bottom thermal pad to the source electrode on PCB

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7.000
1.200
2.000
1.050
3.200
7.950

Land Pattern View

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GaN HEMT Frequently Asked Questions

1	Q: Can we do pin to pin switch for silicon MOSFET or IGBT? A: The short answer is no. GaN HEMT power devices are far superior than the best silicon devices such as super junction MOSFETs. However, due to different requirements of gate driving voltage and extremely high dv/dt slew rate, special drivers and optimized PCB layouts are recommended to minimize the impact from circuit parasitics. Some packaging forms such as GaNPower's DFN packaged devices offer both sense and force for the source terminal. Also, for traditional TO220 packages, please be advised that the pins are arranged as Gate – Source -Drain, and the thermal pad is connected to the source instead of drain.
2	Q: Are GaN power devices reliable? A: GaN power HEMTs have been tested by GaNPower and many other vendors, users and testing facilities to be as reliable (if not better than) silicon counterparts.
3	Q: How do GaN power devices compare with SiC? A: Currently GaN power HEMT devices are most suitable for low to medium voltage (≤1200V) and power (<20KW) applications. GaN is the ideal choice for high frequency applications. SiC devices are better choice for high voltage and high-power applications (>20KW).
4	Q: Do we need to parallel an FRD for applications such as inverters? A: GaN devices are different from silicon MOSFET or IGBT in that they have no inherent PN junction diodes that cause reverse recovery issue. User do not need to parallel an FRD for the purpose of suppressing the body diode reverse recovery effect, since GaN HEMT can operate in both first and third quadrants. However, care should be taken for the dead time power loss since the Vsd voltage of GaN HEMT is usually close to 2V. This is especially true when a negative gate voltage is applied.
6	Q: Can we parallel GaN HEMT devices? A: Yes, GaN HEMT is ideal for paralleling, due to positive temperature coefficient of Rdson and slightly positive temperature coefficient of threshold voltage.
5	Q: Where can we find drivers for GaNPower HEMT devices? A: While some of the GaNPower's HEMTs are either monolithically integrated with gate driver or co-packaged with a silicon driver, drivers can be easily found from vendors such as TI and Silicon Lab for either single sided or half-bridge configurations: ✓ TI: LM5114: Single 7.6A Peak Current Low-Side Gate Driver ✓ TI: UCC27611: 5V, 4A/6A Low Side GaN Driver ✓ Maxim: MAX5048C: 7A Sink/3A Source Current, 8ns, SOT23, MOSFET Drive ✓ Fairchild: FAN3122: Single 9-A High-Speed, Low-Side Gate Driver ✓ Silicon Lab: Si827X: 4 Amp ISO driver with High Transient (dv/dt) Immunity